FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

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APPLICATION NO. Divisional Appln. of Appln. No. 09/523,735

APPLICANT Yasuyuki UNNO

Filed: July 23, 2003

FILING DATE July 23, 2003

GROUP 2851

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		U.S. F	ATENT DOCUMENTS	1	Τ-	
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
211	US-5,040,896 '	08/20/1991	Moslehi	356	351	
24	US-5,117,433 ·	05/26/1992	Tatsuno et al.	372	22	
Plu	US-5,142,548 ·	08/25/1992	Krasinski et al.	372	105	
911	US-5,184,176 ·	02/02/1993	Unno et al.	355	52	
C/L	US-5,459,000 ·	10/17/1995	Unno	430	5	
The	US-5,627,676	05/06/1997	Borrelli et al.	359	494	
PIL	US-5,677,755 '	10/14/1997	Oshida et al.	355	53	
21	US-5,696,628	12/09/1997	Sutton et al.	359	566	
1/2	US-5,805,273	09/08/1998	Unno	355	30	
86	US-5,880,891 ^c	03/09/1999	Fürter	359	651	
PIL	US-5,892,573	04/06/1999	Takahashi et al.	355	69	
THE	US-5,986,733	11/16/1999	Winker et al.	349	120	
71	US-6,055,053.	04/25/2000	Lesniak	356	366	
PK	US-6,057,970 ·	05/02/2000	Kim et al.	359	721	
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	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
Da	8-107060 ·	04/23/1996	Japan			Partial
7K	10-270351	10/09/1998	Japan			Abstract
7.10	WO 98/43135	10/01/1998	Europe			
<i>\(\)</i>	OTHE	R DOCUMENT(S) (Includ	ling Author, Title, Date, Pertinent Pag	es, Etc.)		
ML	E. Mochida, "Optical Technique Contact," Vol. 27, No. 3 (1989), p. 127-134.					
PA	Born, M., et al. "Principles of Optics," 1st Ed., Pergamon Press, New York (1959), pp. 705-708.					
7/6	Aoyama, et al., "Form Birefringence Using Ultra-High Spatial Frequency Gratings," Optics, Vol. 21, No. 5, (1992), pp. 269-274.					
EXAMINER DATE CONSIDERED 12/15/04						

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.